

Notice of References CitedApplication/Control No.
09/665,899Applicant(s)/Patent Under
Reexamination
IWASE ET AL.Examiner
Julian A. MercadoArt Unit
1745

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,840,438	11-1998	Johnson et al.	429/30
	B	US-6,365,295 B1	04-2002	Matsukawa et al.	429/34
	C	US-			
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	N	5-251097	09-1993	Japan	Sugiyama	H01M 8/02
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